Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/669,879	CHEN ET AL.	
Examiner	Art Unit	
Shick C. Hom	2666	

SEARCHED			
Class	Subclass	Date	Examiner
	Updated Search	5/13/2005	SH
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	235, 389,	5/13/2005	SH
370	390, 392,	5/13/2005	SH
370	412, 413,	5/13/2005	SH
	6, 417, 428, 432	5/13/2005	SH

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
East Search	5/13/2005	SH
Inventor search	5/13/2005	SH